Search Notes

Application/Control No.	Applicant(s)/Patent und r R xamination
09/683,432	BENAYOUN ET AL.
Dmitry Levitan	2616

SEARCHED						
Class	Subclass	Date	Examiner			
370	357 360		オム			
	369 - 389					
	389		,			
	395.1	75/3/	06			
	395.3					
	396					
	396 4 <i>00</i> 401					
	401					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE, EAST	5/31/06	R		